

BS ISO 17470:2014



BSI Standards Publication

Microbeam analysis — Electron probe microanalysis — Guidelines for qualitative point analysis by wavelength dispersive X-ray spectrometry

National foreword

This British Standard is the UK implementation of ISO 17470:2014. It supersedes BS ISO 17470:2004 which is withdrawn.

The UK participation in its preparation was entrusted to Technical Committee CII/9, Microbeam analysis.

A list of organizations represented on this committee can be obtained on request to its secretary.

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Amendments issued since publication

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